Search Notes



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Reexamination
KEKRE ET AL.

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FLEURANTIN, JEAN B

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Class	Subclass	Date	Examiner
707	1-10, 100-104.1 & 200-206.	12/15/2008	JBF
710	21 & 33.	12/15/2008	JBF
711	143, 161 & 162.	12/15/2008	JBF

SEARCH NOTES

Search Notes	Date	Examiner
WEST (US PG PUB, US PT, EPO, JPO, DERWENT & IBM TDB).	12/15/2008	JBF
707/ccls & 711/ccls & Inventors Search & Searched (PALM & WEST) for	12/15/2008	JBF
related applications.		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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